# Notice of References Cited

Application/Control No. 09/689,757

Applicant(s)/Patent Under Reexamination LEE ET AL.

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Michael P. Stafira

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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

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